Structure-dynamics relationship in crystallizing poly(ethylene terephthalate) as revealed by time-resolved X-ray and dielectric methods

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Abstract

The isothermal cold crystallization of poly(ethylene terephthalate) was investigated by simultaneous small and wide angle X-ray scattering (SAXS and WAXS) and dielectric spectroscopy (DS). By this experimental approach (SWD), simultaneously collected information was obtained about the specific changes occurring in both crystalline and amorphous phases during crystallization. The main features which are directly derived from our experiments can be explained assuming the formation of a heterogeneous multiple lamellar population arrangement. The rigid amorphous phase can be associated with the intra-lamellar stack amorphous phase. The restriction of the amorphous phase mobility mainly occurs in the inter-lamellar stacks regions probably due to the formation of secondary lamellae.

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1. Introduction

Poly(ethylene terephthalate) (PET) is one of the most common polymer provided by the polymer industry for fiber and packaging purposes \[1,2\]. As a consequence, research in PET has been approached from both technological and basic research sides. In particular, due to the fact that PET can be obtained either in the amorphous state or with a controlled amount of crystallinity, it has been frequently considered as a paradigm of semicrystalline polymers. Therefore, PET has been used to study the influence of crystallinity in a great variety of physical properties including thermal behavior \[3–7\], structure development \[8–11\] and mechanical and dielectric relaxation behavior \[5,12–17\] among others. Although crystallization of PET has been extensively investigated for many years there are several aspects that still remain controversial. On one hand, as far as the crystalline phase is concerned, X-ray scattering and transmission electronic microscopy (TEM) experiments probing the structure development upon crystallization were interpreted invoking the formation of a heterogeneous multiple lamellar population arrangement \[9,18\]. However, recent atomic force microscopy (AFM) studies seem to favor the formation of a more homogeneous lamellar space-filling structure \[11\]. On the other hand, in relation to the evolution of the amorphous phase dynamics during crystallization it was proposed, on the basis of thermal and dielectric analysis, the formation of a rigid amorphous phase located in the interfacial region between the crystalline lamellae and the inter-lamellar amorphous phase \[5,15\]. However, direct observation of the crystal-amorphous interphase in PET by means of AFM seems to indicate that the entire intra-lamellar amorphous phase should be considered as rigid \[19\]. Moreover, unexpectedly high oxygen solubility values of semicrystalline PET have been explained by assuming that the rigid amorphous phase is associated with the inter-lamellar amorphous phase \[20\]. From one experimental point of view, an improvement in the understanding of the correlation between microstructure and crystal development can be obtained by performing simultaneous small and wide angle X-ray scattering (SAXS and WAXS respectively) during isothermal crystallization.
In addition, the information provided by SAXS and WAXS, about the structure of the ordered regions at different length scales, can be complemented simultaneously with that provided by dielectric spectroscopy (DS) about the amorphous phase [22]. Dielectric relaxation takes profit from the fact that, upon crystallization, polymer segmental dynamics is strongly affected by the progressive development of the crystalline phase [13,14,23].

In this paper we present real time isothermal crystallization experiments during cold crystallization of PET as revealed by means of simultaneous small-wide angle X-ray scattering and dielectric spectroscopy (SWD) measurements in real time. Provided that this procedure aims to obtain information from both the crystalline and the amorphous phase we attempt to shed additional light about the above discussed topics.

2. Experimental part

The material used in the present study was a commercial sample of PET (Rhodia S80 from RhodiaSter, \( M_c = 45,000 \text{ g/mol} \)). Amorphous films of 0.2 mm thickness were produced by compression moulding of PET pellets at 300 °C for 3 min and subsequent quenching in ice water. Prior to the hot pressing, the original pellets were dried under vacuum for a given time to eliminate any existing traces of humidity that could cause hydrolysis during the preparation or investigation of the samples. Broad-band DS measurements of the complex dielectric permittivity \( (\varepsilon' = \varepsilon' - i\varepsilon'') \), were performed from \( 10^{-1} \) to \( 10^6 \) Hz by using a BDS-40 Novocontrol system and from \( 10^6 \) to \( 10^7 \) Hz by means of a Novocontrol BDS-60 coaxial line reflectometer. The temperature was controlled by means of a nitrogen gas jet (QUATRO from Novocontrol) with a temperature error of \( \pm 0.1 \) during every single sweep in frequency. Circular gold electrodes were sputtered onto the free surfaces of the films with a diameter of 3 cm for the measurements up to \( 10^6 \) Hz and 0.5 cm for measurements at frequencies \( F > 10^6 \) Hz. Time-resolved SAXS-WAXS-DS experiments were performed in the Soft Condensed Matter beam-line A2 at HASYLAB in the synchrotron facility (DESY in Hamburg, Germany). To enable simultaneous measurements of small- and wide-angle X-ray scattering, as well as of DS in real time, an experimental cell (denominated as SWD) was employed [22]. The SWD cell was incorporated to a vacuum chamber (\( 10^{-2} \text{ Torr} \)) specially designed to perform X-ray scattering measurements with synchrotron radiation. A wavelength \( \lambda = 0.15 \) nm was used for X-ray diffraction study. A semicrystalline PET standard sample was used for the WAXS and rat tendon tail for the SAXS calibration. Each frame was collected during 60 s and later corrected for primary beam intensity fluctuations during experiment and background. Complex dielectric permittivity measurements, \( (\varepsilon'' = \varepsilon''') \) were performed in the frequency range of \( 10^6 \times \text{Hz} < F < 10^5 \text{ Hz} \), using a Novocontrol system integrating a SR 830 Lock-in amplifier with a BDC-L dielectric interface. Circular gold electrodes, 3 cm diameter, were employed to prepare a sandwich type capacitor.

3. Results

3.1. Dielectric relaxation of amorphous PET

Dielectric loss, \( \varepsilon'' \), and dielectric constant data, \( \varepsilon' \), measured in the available frequency window at \( T > T_g \) are shown as a function of frequency for different temperatures in Fig. 1. The broad-band data show not only the \( \alpha \)-relaxation process, at lower frequencies, but also the subglass \( \beta \)-relaxation process at higher frequencies. As expected [14,24,25], the relaxations manifest themselves as maxima in \( \varepsilon'' \) and concurrent steps in \( \varepsilon' \). As the temperature increases the frequencies of maximum loss, \( F_{\text{max}} \), shift towards higher values. At low frequencies the relaxations are accompanied by a strong increase of \( \varepsilon'' \) corresponding to a dc-conductivity contribution. Isothermal \( \varepsilon'' \) and \( \varepsilon' \) data can be phenomenologically described according to the Havrič-Negami [14,26] equation given by:

\[
\varepsilon'' = (\varepsilon_{\infty})_\beta + \sum_{\alpha=\beta}^{c} \frac{(\varepsilon_{\infty} - \varepsilon_{\infty})_\beta}{1 + (i\omega\tau_\beta)^{\alpha}}.
\]

Where \( \varepsilon_{\infty} \) and \( \varepsilon_{\infty} \) are the relaxed (\( \omega = 0 \)) and unrelaxed (\( \omega = \infty \)) dielectric constant values, \( \tau_\beta \) is the central relaxation time of the relaxation time distribution function, and \( b \) and \( c \) \( (0 < b, c \leq 1) \) are shape parameters which

![Fig. 1. (a) Amorphous PET dielectric loss, \( \varepsilon'' \), and (b) dielectric constant, \( \varepsilon' \), values as a function of frequency for different temperatures labeled in °C.](image)
describe respectively the symmetric and the asymmetric broadening of the relaxation time distribution function. The subscript makes reference either to the $\alpha$ or the $\beta$ relaxation. The additional contribution of the conductivity process can be taken into account by adding a term: $-i\sigma(\varepsilon_{\text{vac}}, \omega^2)$ to Eq. (1). Here $\sigma$ is related to the direct current electrical conductivity, $\varepsilon_{\text{vac}}$ is the dielectric constant of vacuum, and the value of the coefficient $0 < s < 1$ depends on the conduction mechanism [27]. The results from this phenomenological data analysis are shown in Fig. 1 by the continuous curves. The characteristic parameters of Eq. (1) are shown in Fig. 2(a) and (b) as a function of temperature. It is noteworthy that no parameter extrapolation from low temperature is needed while fitting the temperature. It is noteworthy that no parameter extrapolation from low temperature is needed while fitting the temperature.

3.2. Time resolved cold crystallization of PET

Fig. 3 shows the time-resolved SAXS-WAXS-DS data simultaneously collected during a cold crystallization experiment at $T_c = 96^\circ$C for three different crystallization times covering the crystallization process. Both, WAXS and Lorentz corrected SAXS intensities [31] are given as a function of the scattering vector $s = (2\pi\sin \theta, 2\theta$ being the scattering angle. The $e^\omega$ data from DS are presented as a function of frequency. The initial amorphous state is characterized by a broad halo in the WAXS diagram, by a continuous scattering in the SAXS pattern, which is due to the liquid-like state, and by the presence of a relaxation process characterized as a maximum in $e^\omega$ centered around a $F_{\text{max}}$ value of $4 \times 10^3$ Hz in the DS data. The observed relaxation can be identified with the $\alpha$-process. As time increases, the onset of crystallization is manifested by the incipient appearance of Bragg peaks in the WAXS patterns characterizing respectively the (010), (1 $-$ 10) and (100) reflections of the triclinic unit cell of PET. The weight fraction index of crystallinity ($X_c$) can be estimated from the ratio between the area below the crystalline Bragg peaks to the total scattered area after appropriate subtraction of a flat background [32]. Dashed lines in Fig. 3 show the peak deconvolution procedure. In the SAXS patterns an increase of the scattered intensity at lower $s$-values that develops into a well defined peak centered around a value of $s = 0.125$ nm$^{-1}$ is observed. This fact indicate that lamellar crystals...
organize themselves forming a nanostructure of lamellar stacks with an average distance between gravity centers of consecutive lamellar crystals of $L = 1/s_{\text{max}} \approx 8$ nm. The above mentioned structural features are accompanied by changes in the dynamics of the amorphous phase as revealed by the simultaneous DS experiment. The $\alpha$-relaxation exhibits, at the end of crystallization a decrease in its intensity and a shift towards lower values of $F_{\text{max}}$. At intermediate crystallization times a significant broadening in the low frequency side of the relaxation is detected. This effect, previously reported by Fukao et al. [33], can be described as an additional $\alpha$-process, $\alpha'$, appearing as crystallinity develops. The dielectric data were analyzed in terms of the HN-equation considering the contribution of (i) the initial $\alpha$-process; (ii) the second $\alpha$-process appearing during crystallization (iii) the $\beta$-relaxation process which contributes in the higher frequency range of the spectrum and (iv) the conductivity which influences the lower frequency part of the spectrum. In this case the NH-equation used for the fittings reads:

$$
\varepsilon^* = \varepsilon_{\infty} + \frac{(\Delta \varepsilon)_a}{[1 + (i\omega\tau_a)^{\beta_a}]^{\gamma_a}} + \frac{(\Delta \varepsilon)_\beta}{[1 + (i\omega\tau_\beta)^{\beta_\beta}]^{\gamma_\beta}} + \frac{(\Delta \varepsilon)_{\beta_0}}{[1 + (i\omega\tau_0)^{\beta_0}]^{\gamma_0}} - \frac{i\sigma}{\varepsilon_{\text{vac}}\omega}.
$$

The separate contribution of every process as well as the total fittings are shown in Fig. 3 by the continuous lines. The initial parameters to simulate the $\beta$-relaxation where taken considering the broad-band data of Fig. 2. A visualization of the changes in the characteristic parameters simultaneously measured is presented in Fig. 4. In this figure we have represented as a function of the crystallization time for both the initial and the secondary $\alpha'$-relaxation process: (a) the dielectric strength, (b) the broadening parameter (c) the asymmetry parameter (d) the central relaxation time. Additionally values for the weight fraction index of crystallinity ($X_c$) are included (Fig. 4(e)) calculated from the WAXS data.

4. Discussion

From the simultaneous SWD-experiments a relationship between structure and dynamics can be attempted. For times shorter than a characteristic one in our case $t \approx 90$ min. at $T = 96$ °C, the initial strong reduction of the mobile material, reflected by the decrease of $\Delta \varepsilon_a$ (Fig. 4(a)), parallels the increase of crystallinity (Fig. 4(e)). However, as observed in a great amount of polymers [13,34], the reduction of the mobile material characterized by the decrease of $\Delta \varepsilon_a$ is stronger than the increment in crystallized material as determined by the increase of $X_c$. This effect can be attributed to the formation of an immobilized amorphous phase frequently referred to as rigid amorphous phase (RAP) [35]. During this initial period of crystallization, in spite of the strong reduction in $\Delta \varepsilon_a$ of about 50%, the remaining mobile material only slightly change the average segmental mobility in the amorphous phase as reflected by the moderate variation observed in $\tau_a$ (Fig. 4(d)). During this initial period the relaxation tends to
Fig. 4. Summary of physical parameters obtained from the SWD experiment for PET at \( T = 96^\circ\) C as a function of the crystallization time: (a) \( \Delta \varepsilon \) values for the \( \alpha \)-relaxation, \( \alpha ' \)-relaxation and \( \alpha'' \)-relaxation. (b) Broadening parameter for the \( \alpha \)-relaxation and \( \alpha ' \)-relaxation. (c) Asymmetry parameter for the \( \alpha \)-relaxation and \( \alpha ' \)-relaxation. (d) Central relaxation times for the \( \alpha \)-relaxation, \( \alpha ' \)-relaxation and \( \alpha'' \)-relaxation. (e) Crystallinity index (left) and slope of the crystallinity curve (right).

become symmetric and increasingly broader, as denoted by the increase of the \( c_{\alpha} \)-parameter and the decrease of the \( b_{\alpha} \)-parameter respectively (Fig. 4(b) and (c)). As crystallization proceeds above the characteristic time, a secondary \( \alpha ' \)-relaxation, \( \alpha ' \), is detectable as a low frequency shoulder in the \( \varepsilon '' \) measurements (Fig. 3). The maximum of the \( \alpha ' \)-relaxation appears at significant lower frequencies, i.e. higher values of \( \tau_{\alpha'} \), as those compared with the initial \( \alpha \)-relaxation. The fittings indicate that the \( \alpha ' \)-relaxation can be described as a symmetric process \( (c_{\alpha'} = 1) \). As crystallization time increases the dielectric strength of the \( \alpha ' \)-relaxation, \( \Delta \varepsilon_{\alpha'} \), tends to increase at expenses of \( \Delta \varepsilon_{\alpha} \) (Fig. 4(a)) as revealed by the moderate variation of the magnitude defined by \( \Delta \varepsilon_{\alpha} + \Delta \varepsilon_{\alpha'} \) (triangles in Fig. 4(a)). At the end of the crystallization process \( \Delta \varepsilon_{\alpha} \) tends to zero and the secondary process becomes the characteristic \( \alpha \)-relaxation of the semi-crystalline material.

The above features, which emerge directly from the simultaneous SAXS, WAXS and DS experiments enable us to propose the following explanation for the cold crystallization of PET. During the initial stages of the process, before the characteristic time, lamellar crystals develop involving a strong formation of rigid amorphous phase as revealed by the increase observed in \( X_c \) and the decrease of \( \Delta \varepsilon_{\alpha} \). In this regime the average mobility of the remaining mobile amorphous phase is slightly affected, as revealed by the small variation with time of \( \tau_{\alpha} \). We propose that the amorphous regions located between consecutive crystals within the lamellar stack become immobilized as soon as the lamellar stack is formed during the initial stages of crystallization before the characteristic time. This could explain the strong reduction of \( \Delta \varepsilon_{\alpha} \) for moderate increase of \( X_c \). A similar model was recently proposed to explain oxygen transport properties of PET [20]. In fact, oxygen permeation measurements indicate that the amorphous region within the lamellar stacks can be associated with the rigid amorphous phase (RAP) [18]. Moreover, recent AFM observations of the inter-lamellar amorphous phase PET indicate that molecular mobility in these regions should be strongly inhibited [19]. Accordingly, in this initial stage, the \( \alpha \)-relaxation could predominantly originate in the inter-lamellar stacks amorphous regions. Around the characteristic time a significantly slower process appears, the \( \alpha ' \)-relaxation. Experiments performed in PET at higher temperatures [36] indicate that the transition from primary to secondary \( \alpha \)-relaxation process occurs upon passing from the initial to the final crystallization regimes. The separation between primary and secondary crystallization has been associated with the moment in which spherulite impingement occurs [37]. After impingement, crystallization can proceed by formation of secondary crystals additionally to the growth of the initial primary crystals. In fast crystallization experiments for PET the transition from primary to secondary crystallization is rather well defined [21,36]. Due to the fact that in the present case cold crystallization takes place relatively close to \( T_g \) the process the crystallinity evolution spreads in time. Thus, the transition from primary to secondary crystallization regimes is not so well defined as for crystallizations at higher temperatures. By calculating the slope of \( X_c \) with time, continuous line referred to the right y-axis, in Fig. 4(e), it is observed that the characteristic time at which the secondary \( \alpha \)-relaxation starts to appear is close to the inflexion point of
the crystallinity curve. This inflexion point can be associated to the moment in which significant impingement of lamellar stacks may locally occur during primary crystallization. After impingement secondary crystals are likely to develop. This suggests that secondary crystals growing in the inter-lamellar stacks amorphous phase may act as physical cross-links tending to slow-down segmental dynamics and giving rise to the secondary α-relaxation. A simplistic scheme of the proposed model is described in Fig. 5. Here Fig. 5(a) represents the initial amorphous state in which only the primary α-relaxation is present. Fig. 5(b) represent the primary lamellar stacks. Here, the segmental mobility of the intra-lamellar stack amorphous phase is arrested and the α-relaxation mainly originates in the inter-lamellar stacks amorphous regions. Thus the overall segmental mobility is essentially similar to the initial one. Fig. 5(c) represents the moment in which secondary crystals start growing in the inter-lamellar stacks amorphous regions. Here it exists a coexistence of the primary α-process, occurring in the inter-lamellar stacks amorphous regions free of secondary lamellae, and of the secondary α-relaxation taking place in the inter-lamellar stacks amorphous regions in which secondary lamellae start to grow. A qualitatively similar model was recently proposed to explain cold crystallization experiments in poly(ether ether ketone)(PEEK) [37] and poly(ethylene naphthalene-2,6-dicarboxylate)(PEN) [38]. Similar results for PET have been previously discussed by Fukao et al. [33]. These authors explained the appearance of the secondary α-process as being characteristic of a coexistence state somehow precursor of the crystalline state. The analysis of our time resolved SWD experiments for PET indicate that also an explanation based on the structural heterogeneity of PET can support the experiments findings without precluding the existence of such a coexistence state in the amorphous phase.

5. Conclusions

In summary, the main features which are directly derived from our simultaneous SAXS, WAXS and DS experiments for the cold crystallization of PET can be explained assuming the formation of a heterogeneous multiple lamellar population arrangement. The rigid amorphous phase can be associated with the intra-lamellar stack amorphous phase. The restriction of the amorphous phase mobility mainly occurs in the inter-lamellar stacks regions probably due to the formation of secondary lamellae.

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